

Notice of References Cited

Application/Control No.

09/727,925

Applicant(s)/Patent Under
Reexamination
HOLTZMAN ET AL.

Examiner

Man Phan

Art Unit

2665

Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-5,065,398	11-1991	Takashima, Hideo	370/230
	B	US-5,742,592	04-1998	Scholefield et al.	370/329
	C	US-6,625,172	09-2003	Odenwalder et al.	370/474
	D	US-6,711,208	03-2004	Razoumov et al.	375/224
	E	US-6,657,980	12-2003	Holtzman et al.	370/329
	F	US-5,752,193	05-1998	Scholefield et al.	455/452.2
	G	US-6,134,261	10-2000	Ryan, David James	375/141
	H	US-6,021,124	02-2000	Haartsen, Jacobus C.	370/336
	I	US-4,645,599	02-1987	Fredkin, Edward	210/416.1
	J	US-5,222,061	06-1993	Doshi et al.	370/394
	K	US-4,970,714	11-1990	Chen et al.	370/216
	L	US-6,396,867	05-2002	Tiedemann et al.	375/141
	M	US-6,545,986	04-2003	Stellakis, Haris M.	370/318

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.